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IRL640A N-Channel Logic Level A-FET 200 V, 18 A, 180 mΩ

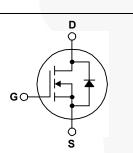
Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar, DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switching DC/DC converters, switch mode power supplies, DC-AC converters for uninterrupted power supply and motor control.

Features

- 18 A, 200 V, $R_{DS(on)}$ = 180 m Ω @ V_{GS} = 5 V
- Low Gate Charge (Typ. 40 nC)
- Low Crss (Typ. 95 pF)
- Fast Switching
- 100% Avalanche Tested
- Improved dv/dt Capability
- Logic-Level Gate Drive





Absolute Maximum Ratings

Symbol	Characteristic	Value	Units	
V _{DSS}	Drain-to-Source Voltage	200	V	
I	Continuous Drain Current (T _C =25°C)	18	_	
Ι _D	Continuous Drain Current (T _c =100°C)	11.4	A	
I _{DM}	Drain Current-Pulsed (1)	63	А	
V _{GS}	Gate-to-Source Voltage	±20	V	
E _{AS}	Single Pulsed Avalanche Energy (2)	64	mJ	
I _{AR}	Avalanche Current (1)	18	A	
E _{AR}	Repetitive Avalanche Energy (1)	11	mJ	
dv/dt	Peak Diode Recovery dv/dt (3)	5	V/ns	
	Total Power Dissipation (T _c =25°C)	110	W	
P_D	Linear Derating Factor	0.88	W/°C	
	Operating Junction and	55 1 150	C	
T_J , T_STG	Storage Temperature Range	- 55 to +150		
-	Maximum Lead Temp. for Soldering	000	°C	
TL	Purposes, 1/8. from case for 5-seconds	300		

Thermal Resistance

Symbol	Characteristic	Тур.	Max.	Units
$R_{ extsf{ heta}JC}$	Junction-to-Case		1.14	
$R_{ extsf{ heta}CS}$	Case-to-Sink	0.5		°C/W
$R_{ extsf{ heta}JA}$	Junction-to-Ambient		62.5	

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity	
IRL640A	IRL640A	TO-220	Tube	N/A	N/A	50 units	

Electrical Characteristics (T_c=25 °C unless otherwise specified)

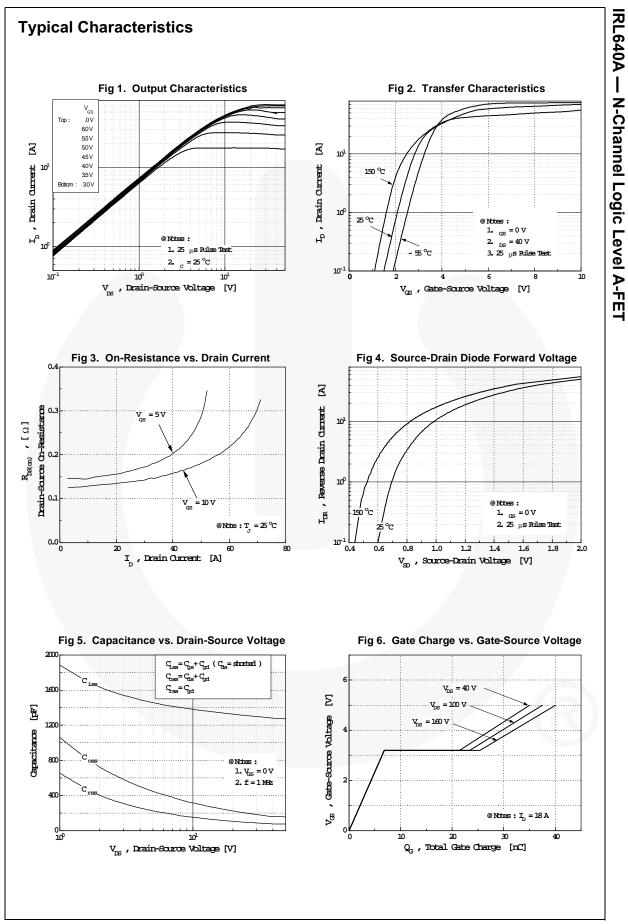
Symbol	Characteristic		Тур.	Max.	Units	Test Condition	
BV _{DSS}	Drain-Source Breakdown Voltage				V	V _{GS} =0V,I _D =250μA	
$\Delta \text{BV} / \Delta \text{T}_{\text{J}}$	Breakdown Voltage Temp. Coeff.		0.17		V/∘C	I _D =250μA See Fig 7	
V _{GS(th)}	Gate Threshold Voltage	1.0		2.0	V	V _{DS} =5V,I _D =250μA	
	Gate-Source Leakage, Forward			100	nA	V _{GS} =20V	
I _{GSS}	Gate-Source Leakage, Reverse			-100	IIA	V _{GS} =-20V	
				10		V _{DS} =200V	
I _{DSS}	Drain-to-Source Leakage Current			100	μA	V _{DS} =160V,T _C =125°C	
R _{DS(on)}	Static Drain-Source On-State Resistance			0.18	Ω	$V_{GS}=5V, I_{D}=9A \qquad (4)$	
9 _{fs}	Forward Transconductance		13.3		Ω	V_{DS} =40V,I _D =9A (4)	
C _{iss}	Input Capacitance		1310	1705			
C _{oss}	Output Capacitance		200	250	рF	V _{GS} =0V,V _{DS} =25V,f =1MHz	
C _{rss}	Reverse Transfer Capacitance		95	120		See Fig 5	
t _{d(on)}	Turn-On Delay Time		11	30		V 100V/1 10A	
t _r	Rise Time Turn-Off Delay Time		8	25	ns	$V_{DD}=100V,I_{D}=18A,$ $R_{G}=4.6\Omega$	
t _{d(off)}			46	100			
t _f	Fall Time		15	40		See Fig 13 (4) (5)	
Qg	Q _{gs} Gate-Source Charge		40	56		V _{DS} =160V,V _{GS} =5V,	
Q_gs			6.8		nC	I _D =18A	
Q_{gd}			18.6			See Fig 6 & Fig 12 (4) (5)	

Source-Drain Diode Ratings and Characteristics

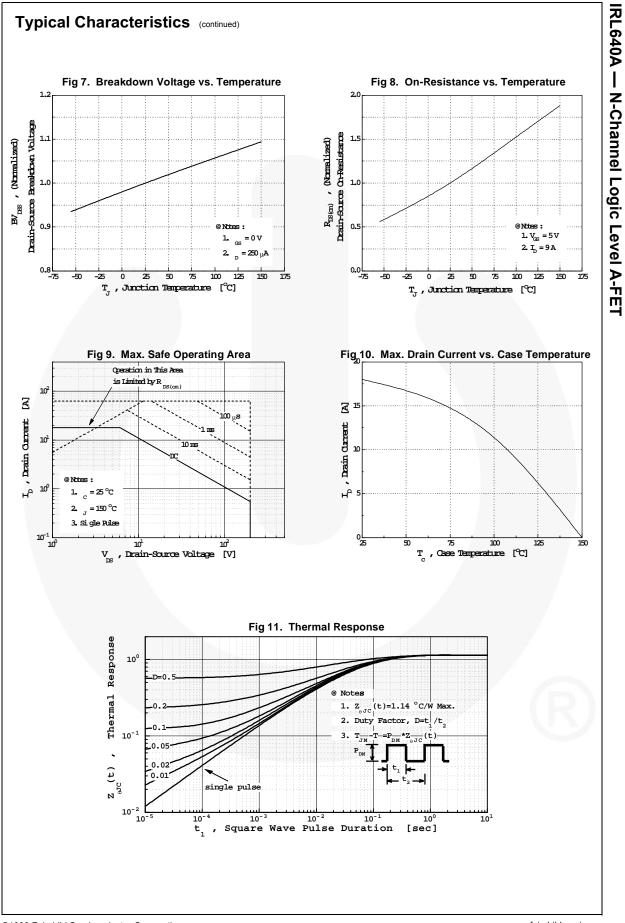
Symbol	Characteristic		Тур.	Max.	Units	Test Condition
ا _s	Continuous Source Current18Pulsed-Source Current(1)63			Integral reverse pn-diode		
I _{SM}				63	A	in the MOSFET
V _{SD}	Diode Forward Voltage (4)			1.5	V	T _J =25°C,I _S =18A,V _{GS} =0V
t _{rr}	Reverse Recovery Time		224		ns	T _J =25°C,I _F =18A
Q _{rr}	Reverse Recovery Charge		1.55		μC	di _F /dt=100A/µs (4)

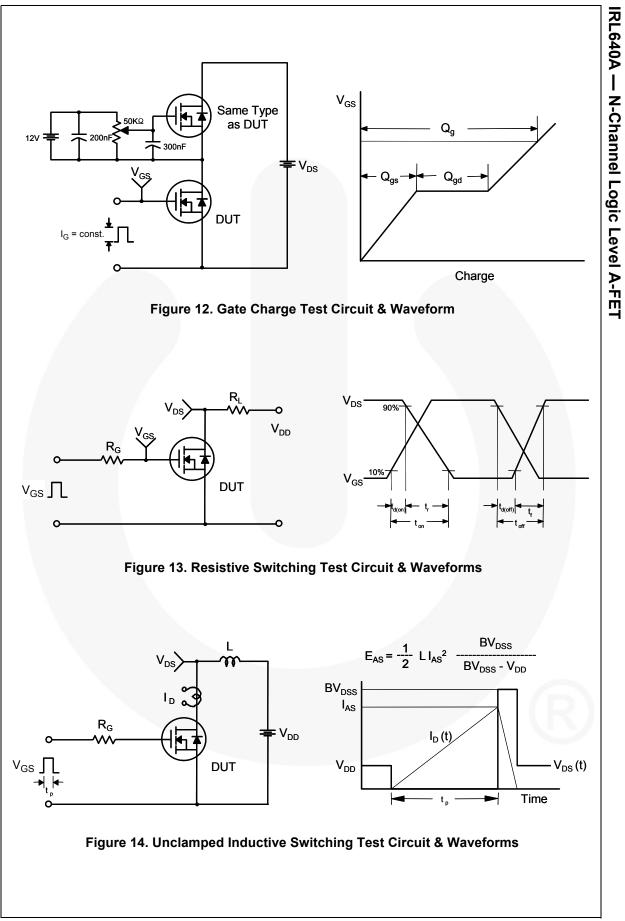
Notes:

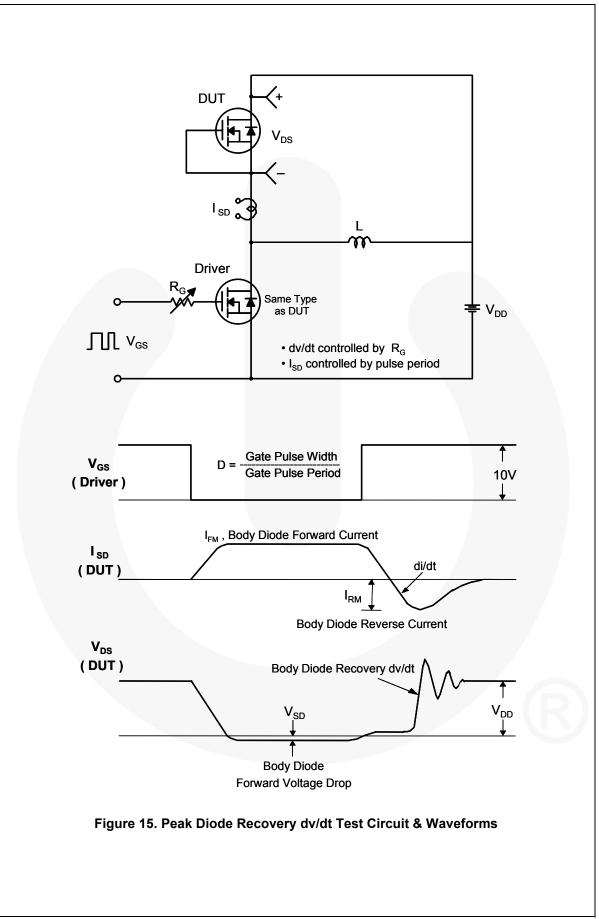
- (1) Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- (2) L=0.3mH, I_{AS}=18A, V_{DD}=50V, R_G=27 Ω , Starting T_J=25°C
- (3) $I_{SD} \le 18A$, di/dt $\le 260A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$ (4) Pulse Test: Pulse Width = 250 μs , Duty Cycle $\le 2\%$
- (5) Essentially Independent of Operating Temperature

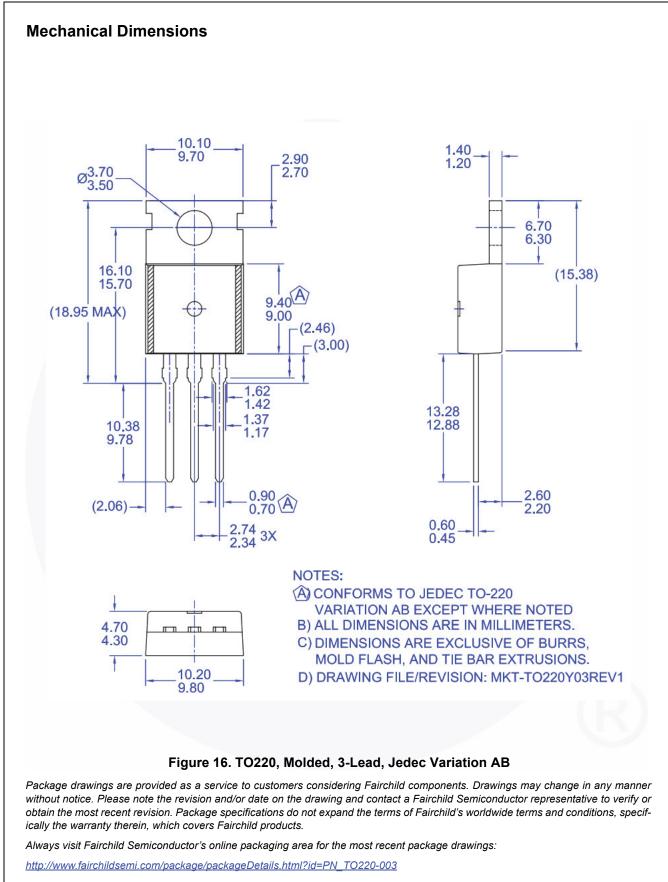


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Datasneet identification	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.
		Rev. 166

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